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Applicants

Banqiu Wu et al.

Serial No.

10/644,358

Filing Date

August 20, 2003

Title

ENDPOINT DETECTION OF PLASMA-ASSISTED

ETCH PROCESS

Examiner

Stephen D. Rosasco

Group Art Unit :

1756

STATUS INQUIRY

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Applicant respectfully inquiries as to the status of the above-identified application. The last correspondence received from the U.S. Patent Office was the Notice of Publication of Application dated February 24, 2005. To date we have not received any further correspondence.

Respectfully submitted,

AMSTER, ROTHSTEIN & EBENSTEIN LLP Attorneys for Applicant 90 Park Avenue New York, NY 10016 (212) 336-8000

Dated: New York, New York

August 17, 2005

Charles R. Macedo Registration No. 32,781